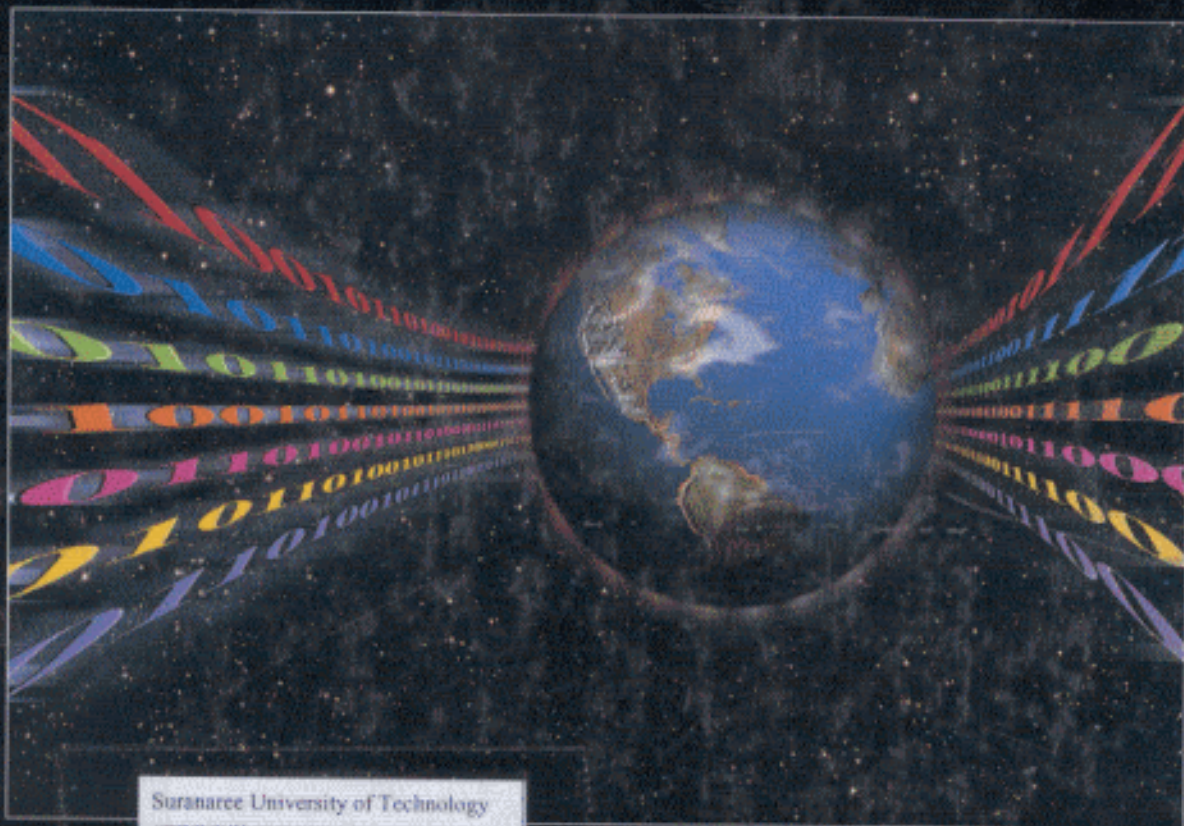


DATA ACQUISITION AND PROCESS CONTROL WITH THE M68HC11 MICROCONTROLLER



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Contents

INTRODUCTION 1

- I.0 The Microcontroller 1
- I.1 Design Procedure 3
- I.2 Problem Solving 3
- I.3 Microcontroller Development Platform 4
- I.4 Software Development 5
- I.5 Microcontroller Development System 7
- I.6 Input: Analog Interface 8
- I.7 Output: Digital Interface 8
- I.8 Conclusion 12

CHAPTER 1 M68HC11 MICROCONTROLLER 13

- 1.0 Introduction 13
- 1.1 M68HC11 Family 14
- 1.2 MC68HC11A8 Microcontroller 15
- 1.3 Package Style and Pin Assignments 18
 - 1.3.1 Power Supply Pins (V_{DD} and V_{SS}) 18
 - 1.3.2 Mode Select Pins ($MODA/\overline{LIR}$ and $MODB/V_{STBY}$) 18
 - 1.3.3 Crystal Oscillator Pins ($EXTAL$, $XTAL$) 20
 - 1.3.4 E Clock Signal 21
 - 1.3.5 Reset Signal 21
 - 1.3.6 Interrupt Pins (IRQ , $\overline{XIRQ}$) 21
 - 1.3.7 Port A/Timer Pins 22
 - 1.3.8 Port B, Port C, $STRA$, and $STRB$ Pins 22
 - 1.3.9 Port D 23
 - 1.3.10 Port E, V_{RL} , and V_{RH} 23
- 1.4 Port Replacement Unit 24
- 1.5 Memory Map 25
- Problems 28

CHAPTER 2 M68HC11 PROGRAMMER'S MODEL AND ADDRESSING MODES 29

2.0	Introduction	29
2.1	Programmer's Model	30
2.2	Accumulators (A and B)	30
2.3	Accumulator D	32
2.4	Condition Code Register (CCR)	32
2.4.1	Carry Flag (C Flag)	33
2.4.2	Overflow Flag (V Flag)	34
2.4.3	Zero Flag (Z Flag)	37
2.4.4	Negative Flag (N Flag)	37
2.4.5	Half-Carry Flag (H Flag)	38
2.4.6	I Interrupt Mask Flag (I Flag)	40
2.4.7	X Interrupt Mask Flag (X Flag)	40
2.4.8	Stop Flag (S Flag)	40
2.5	Index Registers (X and Y)	40
2.6	Stack Pointer (SP)	41
2.7	Program Counter (PC)	42
2.8	Addressing Modes	43
2.8.1	Immediate (IMM)	43
2.8.2	Extended (EXT)	44
2.8.3	Direct (DIR)	45
2.8.4	Inherent (INH)	46
2.8.5	Relative (REL)	46
2.8.6	Indexed (INDX, INDY)	47
2.9	Interrupts	48
	Problems	49

CHAPTER 3 M68HC11 INSTRUCTION SET 51

3.0	Introduction	51
3.1	M68HC11 Instruction Set	52
3.2	Load, Store, Transfer, and Exchange Data Movement Instructions	52
3.3	Arithmetic Instructions	57
3.3.1	Introduction	57
3.3.2	Add Operations	57
3.3.3	Subtract Operations	60
3.3.4	Compare Operations	61
3.3.5	Test Operations	63
3.4	Multiply and Divide Instructions	64
3.5	Logical Operation Instructions	66
3.6	Data Testing and Bit Manipulation Instructions	68
3.7	Shift and Rotate Instructions	70
3.8	Condition Code Register Instructions	74
3.9	Branch Instructions	75
3.9.1	Single Condition Code Branches	76

3.9.2	Unsigned Binary Number Branches	78
3.9.3	Signed Binary Number Branches	79
3.10	Jump and Branch Always Instructions	80
3.11	Subroutine Calls and Return Instructions	81
3.12	Stack Pointer and Index Register Instructions	83
3.13	Interrupt Handling Instructions	84
3.14	Miscellaneous Instructions	84
	Problems	86

CHAPTER 4 PROGRAM DESIGN 89

4.0	Introduction	89
4.1	Top-Down Design	90
4.1.1	Statement of the Problem	91
4.2	Software Tools	93
4.2.1	Editors	93
4.2.2	Assemblers	93
4.2.3	Compilers	94
4.2.4	Linkers and Loaders	94
4.2.5	Debugger	94
4.2.6	Simulator	94
4.3	Position-Independent Code	95
4.4	HC11 Cross-Assembler	95
4.5	Assembler Line Statement Format	96
4.5.1	Label Field	96
4.5.2	Operation Field	97
4.5.3	Operand Field	97
4.5.4	Comment Field	97
4.5.5	Additional Comments	97
4.6	Assembler Directives	98
4.6.1	NAM Directive	98
4.6.2	ORG Directive	99
4.6.3	END Directive	99
4.6.4	EQU Directive	99
4.6.5	FCB Directive	100
4.6.6	FCC Directive	100
4.6.7	RMB Directive	100
4.6.8	SET Directive	101
4.6.9	BTEXT and ETEXT Directives	101
4.7	Control Structures	102
4.7.1	Keywords for Writing HC11 Control Statements	102
4.7.2	Simple Expressions	103
4.7.3	Compound Expressions	105
4.8	Structured Control Statements	106
4.8.1	Conditional Code Statements	106
4.8.2	Loop Control Statements	109

4.9	Nested Loops	114
4.10	Source and Assembler Files	115
4.10.1	Creating the Source File	115
4.10.2	Invoking the Assembler	117
4.10.3	S-Record	119
4.11	Machine Code Generated by the HC11 Cross-Assembler for Different Constructs	121
	Problems	126

CHAPTER 5 DESIGNING AND WRITING PROGRAM MODULES 128

5.0	Introduction	128
5.1	Time Delay	129
5.2	Clear a Memory Buffer	131
5.3	Move a Block of Data	132
5.4	Multiprecision Binary and Decimal Addition	135
5.5	Multiprecision Binary Subtraction	139
5.6	Decimal Subtraction	141
5.7	16-Bit by 8-Bit Binary Multiplication	144
5.8	Decimal Multiplication	146
5.9	Binary-to-BCD Conversion	150
5.10	Laboratory Procedure	153
	Problems	153

CHAPTER 6 EVB COMMANDS, UTILITY SUBROUTINES, AND INTERRUPT VECTORS 155

6.0	Introduction	155
6.1	Power Requirements for the EVB	156
6.2	Initial Setup	156
6.3	Monitor Commands	157
6.4	HELP Command	158
6.5	Register Modify Command	158
6.6	Memory Display	160
6.7	Block Fill Command	161
6.8	MOVE Command	162
6.9	Memory Modify Command	163
6.9.1	Examining a Location	163
6.9.2	Modifying a Location	163
6.9.3	Calculating an Offset	164
6.10	Assembler/Disassembler Command	164
6.11	Go Command	165
6.12	Trace Command	166
6.13	Breakpoint Set Command	166
6.14	Proceed/Continue Command	168
6.15	CALL Command	168
6.16	Utility Subroutines	169

6.17	Interrupt Vectors	179
6.18	Downloading an S-Record File to EVB RAM	181
6.18.1	Accessing KERMIT	181
6.18.2	Connecting to the EVB	182
6.18.3	Preparing the EVB to Receive an S-Record	182
6.18.4	Disconnecting from the EVB	182
6.18.5	Downloading the S-Record File	182
6.18.6	Reconnecting to the EVB	183
6.18.7	Checking the Downloaded Program	183
	Problems	183

CHAPTER 7 THE M68HC11 ANALOG-TO-DIGITAL CONVERTER 186

7.0	Introduction	186
7.1	Analog-to-Digital Converters	187
7.1.1	The Ideal Transfer Function of a Simplified 3-Bit ADC	187
7.1.2	Full-Scale Range and Resolution of the M68HC11 ADC	188
7.1.3	Quantization Error	189
7.1.4	ADC Hardware Equation	191
7.2	Port E	191
7.3	Port E Memory Map Locations	192
7.4	A/D Registers	193
7.4.1	A/D Control-Status Register (ADCTL)	194
7.4.2	Conversion Complete Flag (CCF)—Bit 7	196
7.4.3	Scan Control (SCAN)—Bit 5	196
7.4.4	Multiple/Single Channel Control (MULT)—Bit 4	196
7.4.5	Channel Select Bits (CD, CC, CB, CA)—Bits 3-0	196
7.5	A/D Result Registers (ADR1-ADR4)	198
7.6	Practical Considerations for Inputting Analog Signals to the M68HC11	201
7.6.1	A/D Reference Voltages	201
7.6.2	Limiting A/D Input Current	201
7.7	Measuring a Known Voltage	204
7.8	Measuring an Analog Signal and Displaying a Decimal Value	207
7.9	Improving Analog-to-Digital Converter Accuracy	213
7.9.1	Setting New A/D Reference Voltages for Improved Accuracy	213
7.9.2	Practical Considerations for the EVB System	213
7.9.3	Using the Reduced Range A/D Converter	213
	Problems	215

CHAPTER 8 INTERFACING ANALOG SIGNALS TO THE ADC OF AN M68HC11 216

8.0	Introduction	216
8.1	Connecting an LM335 Directly to the ADC of an MCU	217
8.2	The Analog Interface	219

8.3	Devices Precision SCC Applications	220
8.3.1	Op Amps and IAs for Dual-Supply Applications	220
8.3.2	Op Amps and IAs for Single-Supply Applications	222
8.3.3	Precision Voltage Reference ICs	222
8.4	V-to-V Converters—SCCs and Hardware Equations	224
8.4.1	Introduction	224
8.4.2	Negative Gain SCC—The Single Op Amp Inverting Adder	224
8.4.3	Adding Gain and Offset Adjustment	226
8.4.4	Positive-Gain SCC—The Two Op Amp Adder	228
8.4.5	Adding Gain and Offset Adjustment	229
8.4.6	A Simple Three-Step Calibration Procedure	232
8.5	I-to-V Converters—SCCs and Hardware Equations	233
8.5.1	Positive Slope SCC—Current-to-Voltage Converter	233
8.5.2	Negative Slope SCC—Current-to-Voltage Converter	235
8.6	R-to-V Converters—SCCs and Hardware Equations	237
8.6.1	Introduction to Differential Amplifiers	237
8.6.2	The AD620 Instrumentation Amplifier	238
8.6.3	The LT1101 Single-Supply Instrumentation Amplifier	240
8.6.4	Two-Op Amp Differential Amplifier	240
8.7	Summary of Hardware Equations and SCCs	243
8.8	Designing an Analog Interface for the M68HC11 MCU	244
8.8.1	Introduction	244
8.8.2	Statement of the Problem	244
8.8.3	Deriving the Analog Interface Equation	245
8.8.4	Deriving the Transducer Equation, Step 1	246
8.8.5	SCC Design Equation, Step 2	247
8.8.6	Designing SCC Hardware, Step 3	249
8.9	A Typical Single-Supply SCC Design	252
	Problems	254

CHAPTER 9 SOFTWARE CONTROL OF I/O PORT LINES 257

9.0	Introduction	257
9.1	I/O Ports	258
9.2	Testing an I/O Port	258
9.2.1	Reading Data from an I/O Port	259
9.2.2	Writing Data to an I/O Port	259
9.2.3	Bidirectional Port Lines	260
9.2.4	Port CL	262
9.3	MCU's Main Timing System	262
9.3.1	Prescaler Unit and Timer Counter Register	263
9.4	Timer Overflow	265
9.5	Real-Time Interrupt Function	266
9.6	Output-Compare Function	276

9.7	Pulse Width Modulation	283
9.8	Output-Compare 1 Function	300
9.9	Forced Output Compare	300
9.10	Input-Capture Functions	302
9.10.1	Enable and Status Bits	304
9.11	Pulse Accumulator	306
9.11.1	Event Counting Mode	306
9.11.2	Gated Time Accumulator Mode	312
	Problems	312

CHAPTER 10 OUTPUT PERIPHERALS—INTERFACE DEVICES 314

10.0	Introduction	314
10.1	A Simple Discrete Transistor Interface	314
10.2	Interfacing with TTL Series ICs	316
10.2.1	The 7407 Hex Buffer/Driver	316
10.2.2	The 7405 Hex Inverter	317
10.2.3	Low-Voltage Applications	319
10.2.4	High-Current Applications	320
10.3	Interfacing AC and DC Loads	321
10.3.1	Introduction	321
10.3.2	Characteristics of a Triac Driver	321
10.3.3	Snubber Circuit	322
10.3.4	Industrial-Grade AC and DC Output Modules	323
10.4	Interfacing the MCU to a DC Motor	325
10.4.1	Introduction	325
10.4.2	Pulse-Width Modulation	326
10.4.3	The A3952S Full-Wave PWM Motor Driver	327
10.4.4	Open-Loop Control of a DC Motor	327
	Problems	328

CHAPTER 11 MEASURING PRESSURE WITH SEMICONDUCTOR SENSORS 329

11.0	Introduction	329
11.1	Statement of the Problem	331
11.2	Semiconductor Pressure Sensors	331
11.2.1	Types of Pressure References	331
11.2.2	Units for Pressure Measurement	333
11.2.3	SCX C Series Semiconductor Pressure Sensors	335
11.2.4	Pressure Sensor Specifications	337
11.3	Analog Interface Equation	339
11.4	Designing a Pressure Sensor Interface	341
11.4.1	Bridge Bias	341

11.4.2	Zero Pressure Offset Adjustment	341
11.4.3	Writing the Transducer Equation	341
11.4.4	Writing the SCC Design Equation	343
11.4.5	Designing the SCC Hardware	345
11.4.6	Complete Pressure Sensor System	349
11.5	EVB Program for Pressure Sensor Design	349
	Problems	355
	Questions	356

CHAPTER 12 MEASURING LIQUID VOLUME WITH A FLOWMETER 357

12.0	Introduction	357
12.1	Statement of the Problem	358
12.2	A Liquid Bottle-Fill System	358
12.3	A Commercially Available Precision Flowmeter	360
12.3.1	The IR-Opflow Flowmeter	360
12.3.2	IR-Opflow Flowmeter Operation	361
12.3.3	IR-Opflow Transducer Equation	361
12.4	The Digital Input Interface System	362
12.5	Interfacing an AC Pump Motor to Port B	362
12.6	A Pump for the Liquid Dispensing Problem	363
12.6.1	Selecting the Pump Head	363
12.6.2	Selecting the Pump Tubing	364
12.7	Application Software Design	364
12.7.1	Testing the Software Design	365
	Problems	371

CHAPTER 13 DESIGNING A TEMPERATURE MEASUREMENT SYSTEM WITH MICROCONTROLLER DISPLAY 372

13.0	Introduction	392
13.1	Statement of the Problem	373
13.1.1	Solution	373
13.2	The Analog Interface Equation	374
13.3	The Transducer Equation	375
13.3.1	Introduction	375
13.3.2	The AD590 Transducer Equation	375
13.4	The SCC Design Equation	379
13.5	Designing SCC Hardware	381
13.6	Transducer Self-Heating Error	384
13.6.1	Cause and Effect	384
13.6.2	Minimizing Self-Heating Errors	384
13.7	Calibration Procedure	385
13.7.1	Need for Calibration	385

13.7.2	Circuit Modifications	385
13.7.3	Calibration Procedure	387
13.8	Software Design	387
13.8.1	Initialize the Interval Counter	388
13.8.2	Clear Memory Buffers	388
13.8.3	METEMP Routine	390
13.8.4	HEXBCD Routine	395
13.8.5	RNDOFF Routine	395
13.8.6	OUTPUT Routine	398
13.8.7	TDELAY Routine	398
13.9	Application Program	400
13.10	Testing and Debugging the Application Program	405
13.10.1	Testing the BEGIN and CLEAR Routines	406
13.10.2	Testing the METEMP Routine	406
13.10.3	Testing the HEXBCD Routine	407
	Problems	409
	Questions	410

CHAPTER 14 WEIGHT MEASUREMENTS WITH A LOAD CELL 412

14.0	Introduction	412
14.1	Statement of the Problem	413
14.2	Elements of a Commercial Load Cell	413
14.2.1	Foil-Type Strain-Gage Construction	413
14.2.2	Mounting a Foil-Type Strain Gage	413
14.2.3	Characteristics of a Strain Gage	414
14.2.4	A Platform Load Cell	416
14.2.5	Load Cell Specifications	416
14.3	Analog Interface System	419
14.3.1	Analog Interface Equation	419
14.3.2	Practical Bridge Excitation Circuitry	420
14.3.3	Zero Balance Adjustment	422
14.3.4	Writing the Transducer Equation	422
14.3.5	Writing the SCC Design Equation	424
14.4	Signal Conditioning Circuit: Hardware Design	425
14.4.1	Basic SCC Hardware	425
14.4.2	Practical SCC Hardware for Industrial Usage	428
14.4.3	Interfacing to the 68HC11 MCU	428
14.5	Software Design	430
14.5.1	ENTER and ONE-FOUR Routines	431
14.5.2	PRICE and UNPACK Routines	433
14.5.3	OUTPR Routine	435
14.5.4	WECOST Routine	436
14.5.5	MEASWE Routine	437
14.5.6	COPYWE Routine	437

14.5.7	DECMUL Routine	437
14.5.8	RNDOFF Routine	439
14.6	Application Program	439
14.7	Testing and Debugging the Application Program	452
14.7.1	Using the CALL Command	452
14.7.2	Using the Break Command	454
14.7.3	Using the Trace Command	454
	Problems	455
	Questions	456

CHAPTER 15 THERMOCOUPLE HIGH-TEMPERATURE MEASUREMENT WITH SOFTWARE LINEARIZATION 458

15.0	Introduction	458
15.1	Statement of the Problem	458
15.2	Thermocouple Basics	459
15.2.1	Theory of Operation	459
15.2.2	Thermocouple Reference Tables	459
15.2.3	Thermocouple Temperature Measurement Without an Ice-Point Reference	460
15.2.4	Identifying Thermocouples	462
15.3	Eliminating One Thermocouple	463
15.3.1	Introduction	463
15.3.2	Intermediate Junctions	463
15.3.3	Single Thermocouple Measurement	463
15.4	Cold Junction Compensation	466
15.4.1	Need for Cold Junction Compensation	466
15.4.2	Principle of Cold Junction Compensation	466
15.4.3	LT1025 Micropower Thermocouple Cold Junction Compensator	469
15.5	Thermocouple Transducer Equations	469
15.5.1	Thermocouple Nonlinearity	469
15.5.2	Linear Approximation Equations	469
15.5.3	A Better Offset Linear Approximation	469
15.5.4	Linearization Techniques	473
15.6	Transducer Approximation for Piecewise Software	475
15.6.1	Measuring System Overview	475
15.6.2	Signal Conditioning Circuit Design	475
15.7	Deriving the Programming Linearization Equations	477
15.7.1	Derivation Procedure	477
15.7.2	Constructing the Piecewise-Linear Graph	477
15.7.3	Deriving the Type J Approximation Equations	477
15.7.4	Analog Interface Equations	480
15.7.5	The Programming Equations	481

15.8	Software Design	483
15.8.1	Introduction	483
15.8.2	CLEAR Routine	484
15.8.3	MEASTE Routine	486
15.8.4	BINBCD Routine	486
15.8.5	RANGE Routine	486
15.8.6	EQ/COPY/MOVE Routines	487
15.8.7	DECADD Routine	487
15.8.8	DECMUL Routine	487
15.8.9	OUTPUT Routine	489
15.8.10	TDELAY Routine	489
15.9	Software Linearization Application Program	489
15.10	Testing and Debugging the Application Program	497
15.10.1	Simulating an SCC Voltage Input	498
	Problems	500
	Questions	500

APPENDIX A	INSTRUCTION SET DETAILS	503
APPENDIX B	INSTRUCTION SET SUMMARY	616
APPENDIX C	M68HC11 OP-CODES	633
APPENDIX D	INTERRUPT VECTOR FLOWCHARTS	637
APPENDIX E	ASCII CHARACTER SET	642
APPENDIX F	M68HC24 PORT REPLACEMENT UNIT	643
APPENDIX G	OP-177	661
APPENDIX H	AD820	672
APPENDIX I	AD620	688
APPENDIX J	LT1025	704
APPENDIX K	AD REF01, AD REF02, AD REF03	712
APPENDIX L	FULL-BRIDGE 3952	718
APPENDIX M	LM335 PRECISION TEMPERATURE SENSORS	733
APPENDIX N	AD590	744
APPENDIX O	PRESSURE SENSOR	754
APPENDIX P	PLATFORM LOAD CELL	760
APPENDIX Q	STANDARD 1% RESISTOR VALUES	764
APPENDIX R	FLOW METER	765

INDEX	769
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